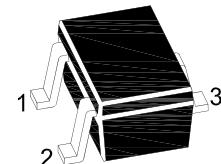
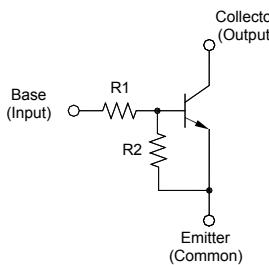


# MMDTC143ZE

## NPN Silicon Epitaxial Planar Digital Transistor

### Features

- With built-in bias resistors
- Simplify circuit design
- Reduce a quantity of parts and manufacturing process



1.Base 2.Emitter 3.Collector  
SOT-523 Plastic Package

### Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

Parameter	Symbol	Value	Unit
Collector Emitter Voltage	$V_{CEO}$	50	V
Input Voltage	$V_I$	- 5 to + 30	V
Collector Current	$I_C$	100	mA
Power Dissipation	$P_{tot}$	150	mW
Junction Temperature	$T_j$	150	°C
Storage Temperature Range	$T_{stg}$	- 55 to + 150	°C

### Characteristics at $T_a = 25^\circ\text{C}$

Parameter	Symbol	Min.	Typ.	Max.	Unit
DC Current Gain at $V_{CE} = 5$ V, $I_C = 10$ mA	$h_{FE}$	80	-	-	-
Collector Base Cutoff Current at $V_{CB} = 50$ V	$I_{CBO}$	-	-	0.5	µA
Emitter Base Cutoff Current at $V_{EB} = 5$ V	$I_{EBO}$	-	-	1.8	mA
Collector Emitter Saturation Voltage at $I_C = 5$ mA, $I_B = 0.25$ mA	$V_{CE(sat)}$	-	-	0.3	V
Input on Voltage at $V_{CE} = 0.3$ V, $I_C = 5$ mA	$V_{I(on)}$	-	-	1.3	V
Input off Voltage at $V_{CE} = 5$ V, $I_C = 100$ µA	$V_{I(off)}$	0.5	-	-	V
Transition frequency at $V_{CE} = 10$ V, $-I_E = 5$ mA, $f = 100$ MHz	$f_T$	-	250	-	MHz
Input Resistance	$R_1$	3.29	4.7	6.11	KΩ
Resistance Ratio	$R_2 / R_1$	8	10	12	-

**TOP DYNAMIC**



ISO14001 : 2004 ISO 9001 : 2008 OHSAS 18001 : 2007 IECQ QC 080000  
Certificate No. 121505007 Certificate No. 50114012 Certificate No. 0513150008 Certificate No. ESD/14001/1002

Dated : 22/12/2012 Rev:02

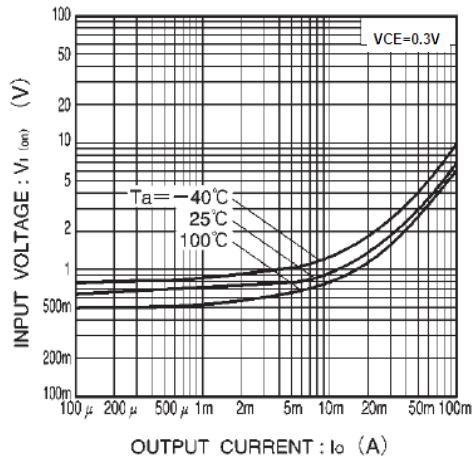


Fig.1 Input voltage vs. output current  
(ON characteristics)

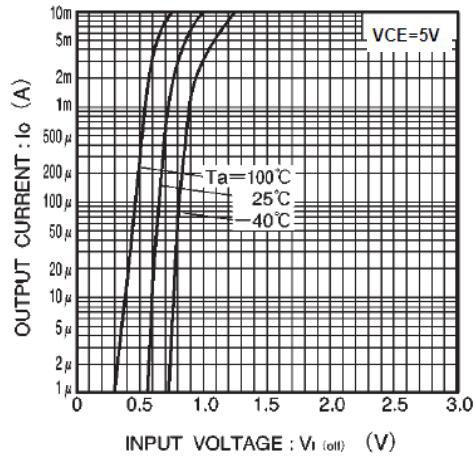


Fig.2 Output current vs. input voltage  
(OFF characteristics)

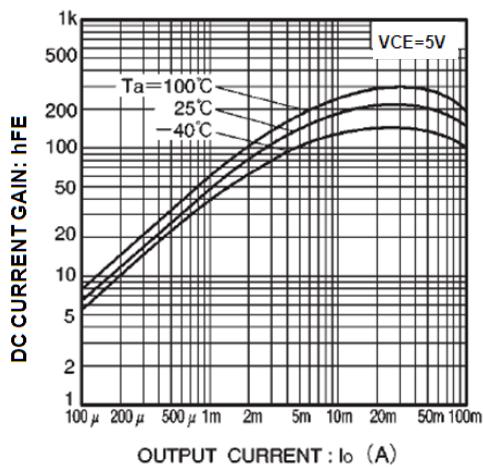


Fig.3 DC current gain vs. output current

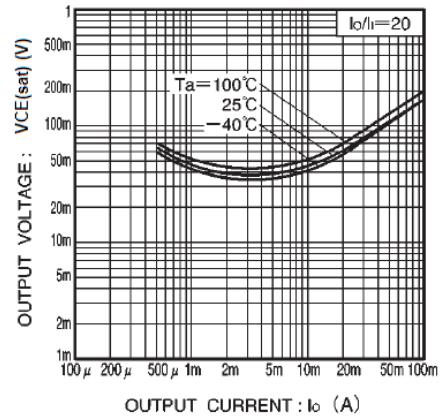


Fig.4 Output voltage vs. output current

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